

# DDR3 SDRAM RDIMM

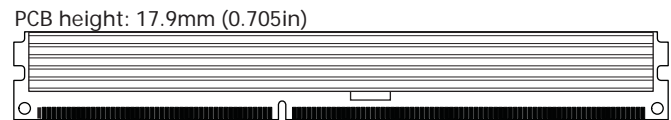
## MT36JBZS51272PD – 4GB

For component data sheets, refer to Micron's Web site: [www.micron.com](http://www.micron.com)

### Features

- DDR3 functionality and operations supported as defined in the component data sheet
- 240-pin, very low profile registered dual in-line memory module (VLP RDIMM)
- Compatible with ATCA form factors
- Fast data transfer rates: PC3-10600, PC3-8500, or PC3-6400
- 4GB (512 Meg x 72)
- $V_{DD} = 1.5V \pm 0.075V$
- $V_{DDSPD} = +3.0V$  to  $+3.6V$
- Supports ECC error detection and correction
- Nominal and dynamic on-die termination (ODT) for data and strobe signals
- Quad rank, using 2Gb TwinDie™ devices
- 8 internal device banks
- Fixed burst chop (BC) of 4 and burst length (BL) of 8 via the mode register set (MRS)
- On-board I<sup>2</sup>C temperature sensor with integrated serial presence-detect (SPD) EEPROM
- Gold edge contacts
- Pb-free
- Fly-by topology
- Terminated control, command, and address bus

**Figure 1: 240-Pin VLP RDIMM (ATCA-Compatible R/C V)**



### Options

- Operating temperature<sup>1</sup>
  - Commercial ( $0^{\circ}C \leq T_A \leq +70^{\circ}C$ )
  - Industrial ( $-40^{\circ}C \leq T_A \leq +85^{\circ}C$ )
- Package
  - 240-pin DIMM (lead-free)
- Frequency/CAS latency
  - 1.5ns @ CL = 9 (DDR3-1333)
  - 1.5ns @ CL = 10 (DDR3-1333)<sup>2</sup>
  - 1.87ns @ CL = 7 (DDR3-1066)
  - 1.87ns @ CL = 8 (DDR3-1066)<sup>2</sup>
  - 2.5ns @ CL = 5 (DDR3-800)<sup>2</sup>
  - 2.5ns @ CL = 6 (DDR3-800)<sup>2</sup>

### Marking

|      |
|------|
| None |
| I    |
| Y    |
| -1G4 |
| -1G3 |
| -1G1 |
| -1G0 |
| -80C |
| -80B |

Notes: 1. Contact Micron for industrial temperature module offerings.  
2. Not recommended for new designs.

**Table 1: Key Timing Parameters**

| Speed Grade | Industry Nomenclature | Data Rate (MT/s) |        |        |        |        |        | t <sub>RCD</sub> (ns) | t <sub>RP</sub> (ns) | t <sub>RC</sub> (ns) |
|-------------|-----------------------|------------------|--------|--------|--------|--------|--------|-----------------------|----------------------|----------------------|
|             |                       | CL = 10          | CL = 9 | CL = 8 | CL = 7 | CL = 6 | CL = 5 |                       |                      |                      |
| -1G4        | PC3-10600             | 1333             | 1333   | 1066   | 1066   | 800    | –      | 13.5                  | 13.5                 | 49.5                 |
| -1G3        | PC3-10600             | 1333             | –      | 1066   | –      | 800    | –      | 15                    | 15                   | 51                   |
| -1G1        | PC3-8500              | –                | –      | 1066   | 1066   | 800    | –      | 13.125                | 13.125               | 50.625               |
| -1G0        | PC3-8500              | –                | –      | 1066   | –      | 800    | –      | 15                    | 15                   | 52.5                 |
| -80C        | PC3-6400              | –                | –      | –      | –      | 800    | 800    | 12.5                  | 12.5                 | 50                   |
| -80B        | PC3-6400              | –                | –      | –      | –      | 800    | –      | 15                    | 15                   | 52.5                 |

**Table 2: Addressing**

| Parameter            | 4GB                       |
|----------------------|---------------------------|
| Refresh count        | 8K                        |
| Row address          | 16K (A[13:0])             |
| Device bank address  | 8 (BA[2:0])               |
| Device configuration | 2Gb TwinDie (256 Meg x 8) |
| Column address       | 2K (A[9:0])               |
| Module rank address  | 4 (S#[3:0])               |

**Table 3: Part Numbers and Timing Parameters – 4GB Modules**

Base device: MT41J128M8,<sup>1</sup> 2Gb TwinDie DDR3 SDRAM

| Part Number <sup>2</sup>  | Module Density | Configuration | Module Bandwidth | Memory Clock/<br>Data Rate | Clock Cycles<br>(CL- <sup>t</sup> RCD- <sup>t</sup> RP) |
|---------------------------|----------------|---------------|------------------|----------------------------|---|
| MT36JBZS51272PD(I)Y-1G4__ | 4GB            | 512 Meg x 72  | 10.6 GB/s        | 1.5ns/1333 MT/s            | 9-9-9   |
| MT36JBZS51272PD(I)Y-1G3__ | 4GB            | 512 Meg x 72  | 10.6 GB/s        | 1.5ns/1333 MT/s            | 10-10-10  |
| MT36JBZS51272PD(I)Y-1G1__ | 4GB            | 512 Meg x 72  | 8.5 GB/s         | 1.87ns/1066 MT/s           | 7-7-7   |
| MT36JBZS51272PD(I)Y-1G0__ | 4GB            | 512 Meg x 72  | 8.5 GB/s         | 1.87ns/1066 MT/s           | 8-8-8   |
| MT36JBZS51272PD(I)Y-80C__ | 4GB            | 512 Meg x 72  | 6.4 GB/s         | 2.5ns/800 MT/s             | 5-5-5   |
| MT36JBZS51272PD(I)Y-80B__ | 4GB            | 512 Meg x 72  | 6.4 GB/s         | 2.5ns/800 MT/s             | 6-6-6   |

- Notes:
1. The data sheet for the base device can be found on Micron's Web site.
  2. All part numbers end with a two-place code (not shown) that designates component and PCB revisions. Consult factory for current revision codes.  
Example: MT36JBZS51272PDY-1G1D1.

## Pin Assignments and Descriptions

**Table 4: Pin Assignments**

| 240-Pin DDR3 RDIMM Front |        |     |          |     |        |     |        | 240-Pin DDR3 RDIMM Back |                |     |                |     |                |     |                |
|--------------------------|--------|-----|----------|-----|--------|-----|--------|-------------------------|----------------|-----|----------------|-----|----------------|-----|----------------|
| Pin                      | Symbol | Pin | Symbol   | Pin | Symbol | Pin | Symbol | Pin                     | Symbol         | Pin | Symbol         | Pin | Symbol         | Pin | Symbol         |
| 1                        | VREFDQ | 31  | DQ25     | 61  | A2     | 91  | DQ41   | 121                     | Vss            | 151 | Vss            | 181 | A1             | 211 | Vss            |
| 2                        | Vss    | 32  | Vss      | 62  | VDD    | 92  | Vss    | 122                     | DQ4            | 152 | DM3/<br>TDQS12 | 182 | VDD            | 212 | DM5/<br>TDQS14 |
| 3                        | DQ0    | 33  | DQS3#    | 63  | NC     | 93  | DQS5#  | 123                     | DQ5            | 153 | NU/<br>TDQS12# | 183 | VDD            | 213 | NU/<br>TDQS14# |
| 4                        | DQ1    | 34  | DQS3     | 64  | NC     | 94  | DQS5   | 124                     | Vss            | 154 | Vss            | 184 | CK0            | 214 | Vss            |
| 5                        | Vss    | 35  | Vss      | 65  | VDD    | 95  | Vss    | 125                     | DM0/<br>TDQS9  | 155 | DQ30           | 185 | CK0#           | 215 | DQ46           |
| 6                        | DQS0#  | 36  | DQ26     | 66  | VDD    | 96  | DQ42   | 126                     | NU/<br>TDQS9#  | 156 | DQ31           | 186 | VDD            | 216 | DQ47           |
| 7                        | DQS0   | 37  | DQ27     | 67  | VREFCA | 97  | DQ43   | 127                     | Vss            | 157 | Vss            | 187 | EVENT#         | 217 | Vss            |
| 8                        | Vss    | 38  | Vss      | 68  | PAR_IN | 98  | Vss    | 128                     | DQ6            | 158 | CB4            | 188 | A0             | 218 | DQ52           |
| 9                        | DQ2    | 39  | CB0      | 69  | VDD    | 99  | DQ48   | 129                     | DQ7            | 159 | CB5            | 189 | VDD            | 219 | DQ53           |
| 10                       | DQ3    | 40  | CB1      | 70  | A10    | 100 | DQ49   | 130                     | Vss            | 160 | Vss            | 190 | BA1            | 220 | Vss            |
| 11                       | Vss    | 41  | Vss      | 71  | BA0    | 101 | Vss    | 131                     | DQ12           | 161 | DM8/<br>TDQS17 | 191 | VDD            | 221 | DM6/<br>TDQS15 |
| 12                       | DQ8    | 42  | DQS8#    | 72  | VDD    | 102 | DQS6#  | 132                     | DQ13           | 162 | NU/<br>TDQS17# | 192 | RAS#           | 222 | NU/<br>TDQS15# |
| 13                       | DQ9    | 43  | DQS8     | 73  | WE#    | 103 | DQS6   | 133                     | Vss            | 163 | Vss            | 193 | S0#            | 223 | Vss            |
| 14                       | Vss    | 44  | Vss      | 74  | CAS#   | 104 | Vss    | 134                     | DM0/<br>TDQS9  | 164 | CB6            | 194 | VDD            | 224 | DQ54           |
| 15                       | DQS1#  | 45  | CB2      | 75  | VDD    | 105 | DQ50   | 135                     | NU/<br>TDQS9#  | 165 | CB7            | 195 | ODT0           | 225 | DQ55           |
| 16                       | DQS1   | 46  | CB3      | 76  | S1#    | 106 | DQ51   | 136                     | Vss            | 166 | Vss            | 196 | A13            | 226 | Vss            |
| 17                       | Vss    | 47  | Vss      | 77  | ODT1   | 107 | Vss    | 137                     | DQ14           | 167 | NC             | 197 | VDD            | 227 | DQ60           |
| 18                       | DQ10   | 48  | VTT      | 78  | VDD    | 108 | DQ56   | 138                     | DQ15           | 168 | RESET#         | 198 | S3#            | 228 | DQ61           |
| 19                       | DQ11   | 49  | VTT      | 79  | S2#    | 109 | DQ57   | 139                     | Vss            | 169 | CKE1           | 199 | Vss            | 229 | Vss            |
| 20                       | Vss    | 50  | CKE0     | 80  | Vss    | 110 | Vss    | 140                     | DQ20           | 170 | VDD            | 200 | DQ36           | 230 | DM7/<br>TDQS16 |
| 21                       | DQ16   | 51  | VDD      | 81  | DQ32   | 111 | DQS7#  | 141                     | DQ21           | 171 | A15            | 201 | DQ37           | 231 | NU/<br>TDQS16# |
| 22                       | DQ17   | 52  | BA2      | 82  | DQ33   | 112 | DQS7   | 142                     | Vss            | 172 | A14            | 202 | Vss            | 232 | Vss            |
| 23                       | Vss    | 53  | ERR_OUT# | 83  | Vss    | 113 | Vss    | 143                     | DM2/<br>TDQS11 | 173 | VDD            | 203 | DM4/<br>TDQS13 | 233 | DQ62           |
| 24                       | DQS2#  | 54  | VDD      | 84  | DQS4#  | 114 | DQ58   | 144                     | NU/<br>TDQS11# | 174 | A12            | 204 | NU/<br>TDQS13# | 234 | DQ63           |
| 25                       | DQS2   | 55  | A11      | 85  | DQS4   | 115 | DQ59   | 145                     | Vss            | 175 | A9             | 205 | Vss            | 235 | Vss            |
| 26                       | Vss    | 56  | A7       | 86  | Vss    | 116 | Vss    | 146                     | DQ22           | 176 | VDD            | 206 | DQ38           | 236 | VDDSPD         |
| 27                       | DQ18   | 57  | VDD      | 87  | DQ34   | 117 | SA0    | 147                     | DQ23#          | 177 | A8             | 207 | DQ39           | 237 | SA1            |
| 28                       | DQ19   | 58  | A5       | 88  | DQ35   | 118 | SCL    | 148                     | Vss            | 178 | A6             | 208 | Vss            | 238 | SDA            |
| 29                       | Vss    | 59  | A4       | 89  | Vss    | 119 | SA2    | 149                     | DQ28           | 179 | VDD            | 209 | DQ44           | 239 | Vss            |
| 30                       | DQ24   | 60  | VDD      | 90  | DQ40   | 120 | VTT    | 150                     | DQ29           | 180 | A3             | 210 | DQ45           | 240 | VTT            |

**Table 5: Pin Descriptions**

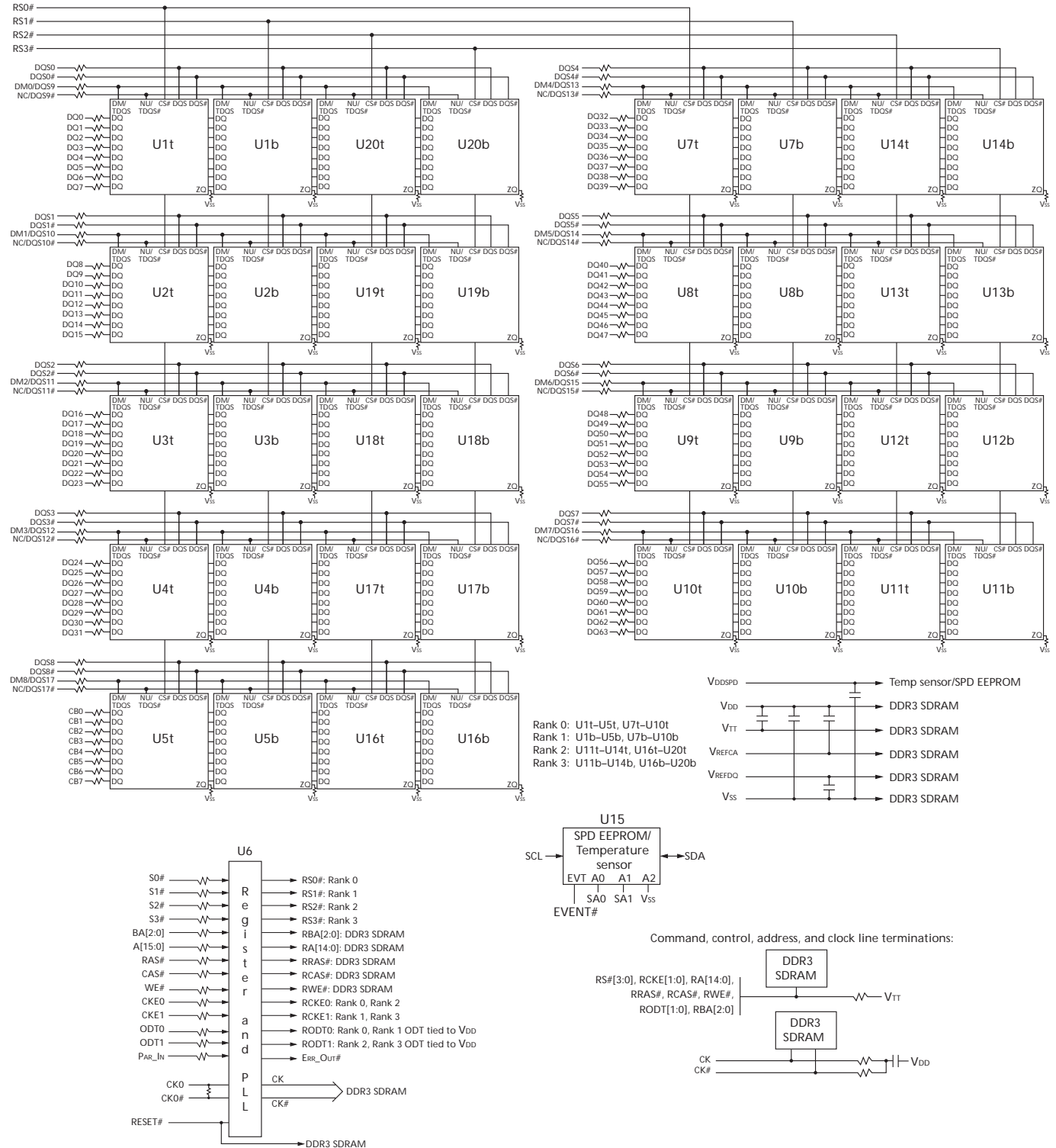
| Symbol                                  | Type                   | Description   |
|---|------------------------|---|
| A[15:0]                                 | Input                  | <b>Address inputs:</b> Provide the row address for ACTIVATE commands, and the column address and auto precharge bit (A10) for READ/WRITE commands, to select one location out of the memory array in the respective bank. A10 is sampled during a PRECHARGE command to determine whether the PRECHARGE applies to one bank (A10 LOW, bank selected by BA[2:0]) or all banks (A10 HIGH). If only one bank is to be precharged, the bank is selected by BA. A12 is also used for BC4/BL8 identification as “BL on-the-fly” during CAS commands. The address inputs also provide the op-code during the mode register command set. A[13:0] address the 2Gb TwinDie DDR3 devices. A[15:14] are needed to calculate parity on the command/address bus. |
| BA[2:0]                                 | Input                  | <b>Bank address inputs:</b> BA[2:0] define the device bank to which an ACTIVATE, READ, WRITE, or PRECHARGE command is being applied. BA[2:0] define which mode register (MR0, MR1, MR2, and MR3) is loaded during the LOAD MODE command. BA[2:0] are used as part of the parity calculation.  |
| CK0, CK0#                               | Input                  | <b>Clock:</b> CK and CK# are differential clock inputs. All control, command, and address input signals are sampled on the crossing of the positive edge of CK and the negative edge of CK#.  |
| CKE[1:0]                                | Input                  | <b>Clock enable:</b> CKE enables (registered HIGH) and disables (registered LOW) internal circuitry and clocks on the DRAM.   |
| DM[8:0]<br>(TDQS[17:9],<br>TDQS#[17:9]) | Input                  | <b>Input data mask:</b> DM is an input mask signal for write data. Input data is masked when DM is sampled HIGH, along with the input data, during a write access. DM is sampled on both edges of the DQS. Although the DM pins are input-only, the DM loading is designed to match that of the DQ and DQS pins. When TDQS is enabled, DM is disabled and TDQS and TDQS# provide termination resistance; otherwise, the TDQS# pins are no function.   |
| ODT[1:0]                                | Input                  | <b>On-die termination:</b> ODT enables (registered HIGH) and disables (registered LOW) termination resistance internal to the DRAM. When enabled in normal operation, ODT is only applied to the following pins: DQ, DQS, DQS#, and DM. The ODT input will be ignored if disabled via the LOAD MODE command.  |
| PAR_IN                                  | Input                  | <b>Parity input:</b> Parity bit for the command and address bus.  |
| RAS#, CAS#, WE#                         | Input                  | <b>Command inputs:</b> RAS#, CAS#, and WE# (along with S#) define the command being entered.  |
| RESET#                                  | Input<br>(LVCMOS)      | <b>Reset:</b> RESET# is an active LOW CMOS input referenced to Vss. The RESET# input receiver is a CMOS input defined as a rail-to-rail signal with DC HIGH $\geq 0.8 \times V_{DD}$ and DC LOW $\leq 0.2 \times V_{DD}$ . RESET# assertion and deassertion are asynchronous.   |
| S#[3:0]                                 | Input                  | <b>Chip select:</b> S# enables (registered LOW) and disables (registered HIGH) the command decoder.   |
| SA[2:0]                                 | Input                  | <b>Serial address inputs:</b> These pins are used to configure the temperature sensor/SPD EEPROM address range on the I <sup>2</sup> C bus.   |
| SCL                                     | Input                  | <b>Serial clock for temperature sensor/SPD EEPROM:</b> SCL is used to synchronize the communication to and from the temperature sensor/SPD EEPROM.  |
| CB[7:0]                                 | I/O                    | <b>Check bits:</b> Data used for ECC.   |
| DQ[63:0]                                | I/O                    | <b>Data input/output:</b> Bidirectional data bus.   |
| DQS[8:0],<br>DQS#[8:0]                  | I/O                    | <b>Data strobe:</b> DQS and DQS# are differential data strobes. Output with read data. Edge-aligned with read data. Input with write data. Center-aligned with write data.  |
| SDA                                     | I/O                    | <b>Serial data:</b> SDA is a bidirectional pin used to transfer addresses and data into and out of the temperature sensor/SPD EEPROM on the module on the I <sup>2</sup> C bus.   |
| ERR_OUT#                                | Output<br>(open drain) | <b>Parity error output:</b> Parity error found on the command and address bus.  |

Table 5: Pin Descriptions (continued)

| Symbol | Type                | Description   |
|--------|---------------------|---|
| EVENT# | Output (open drain) | <b>Temperature event:</b> The EVENT# pin is asserted by the temperature sensor when critical temperature thresholds have been exceeded. |
| VDD    | Supply              | <b>Power supply (1.5V ±0.075V):</b> The component VDD and VDDQ are connected to the module VDD.   |
| VDDSPD | Supply              | <b>Temperature sensor/SPD EEPROM power supply:</b> +3.0V to +3.6V.  |
| VREFCA | Supply              | <b>Reference voltage:</b> Control, command, and address (VDD/2).  |
| VREFDQ | Supply              | <b>Reference voltage:</b> DQ, DM (VDD/2).   |
| VSS    | Supply              | Ground.   |
| VTT    | Supply              | <b>Termination voltage:</b> Used for control, command, and address (VDD/2).   |
| NC     | -                   | <b>No connect:</b> These pins are not connected on the module.  |
| NU     | -                   | <b>Not used:</b> These pins are not used in specific module configuration/operations.   |

## Functional Block Diagram

Figure 2: Functional Block Diagram



Notes: 1. The ZQ ball on each DDR3 component is connected to an external 240Ω ±1% resistor that is tied to ground. It is used for the calibration of the component's ODT and output driver.

## General Description

The MT36JBZS51272PDY DDR3 SDRAM module is a high-speed, CMOS dynamic random-access 4GB memory module organized in a x72 configuration. This DDR3 SDRAM module uses internally configured, 8-bank 2Gb TwinDie DDR3 SDRAM devices.

DDR3 SDRAM modules use double data rate architecture to achieve high-speed operation. The double data rate architecture is essentially an  $8n$ -prefetch architecture with an interface designed to transfer two data words per clock cycle at the I/O pins. A single read or write access for the DDR3 SDRAM module effectively consists of a single  $8n$ -bit-wide, one-clock-cycle data transfer at the internal DRAM core and eight corresponding  $n$ -bit-wide, one-half-clock-cycle data transfers at the I/O pins.

The differential data strobe (DQS, DQS#) is transmitted externally, along with data, for use in data capture at the DDR3 SDRAM input receiver. DQS is center-aligned with data for WRITES. The read data is transmitted by the DDR3 SDRAM and edge-aligned to the data strobes.

DDR3 SDRAM modules operate from a differential clock (CK and CK#); the crossing of CK going HIGH and CK# going LOW will be referred to as the positive edge of CK. Control, command, and address signals are registered at every positive edge of CK. Input data is registered on both edges of DQS, and output data is referenced to both edges of DQS, as well as to both edges of CK.

## Fly-By Topology

These DDR3 modules use faster clock speeds than earlier DDR technologies, making signal quality more important than ever. For improved signal quality, the clock, control, command, and address buses have been routed in a fly-by topology, where each clock, control, command, and address pin on each DRAM is connected to a single trace and terminated (rather than a tree structure, where the termination is off the module near the connector). Inherent to fly-by topology, the timing skew between the clock and DQS signals can be easily accounted for by using the write-leveling feature of DDR3.

## Registering Clock Driver Operation

Registered DDR3 SDRAM modules use a registering clock driver consisting of a register and a phase-lock loop (PLL) and comply with the JEDEC standard "Definition of the SSTE32882 Registering Clock Driver with Parity and Quad Chip Selects for DDR3 RDIMM Applications."

The register section of the registering clock driver latches command and address input signals on the rising clock edge. The PLL section of the registering clock driver receives and redrives the differential clock signals (CK, CK#) to the DDR3 SDRAM devices. The register(s) and PLL reduce clock, control, command, and address signals loading by isolating DRAM from the system controller.

## Temperature Sensor with Serial Presence-Detect EEPROM

### Thermal Sensor Operations

The temperature from the integrated thermal sensor is monitored and converts into a digital word via the I2C bus. System designers can use the user-programmable registers to create a custom temperature-sensing solution based on system requirements. Programming and configuration details comply with JEDEC standard No. 21-C page 4.7-1 “Mobile Platform Memory Module Thermal Sensor Component Specification.”

### Serial Presence-Detect EEPROM Operation

DDR3 SDRAM modules incorporate serial presence-detect. The SPD data is stored in a 256-byte EEPROM. The first 128 bytes are programmed by Micron to comply with JEDEC standard JC-45 “Appendix X: Serial Presence Detect (SPD) for DDR3 SDRAM Modules.” These bytes identify module-specific timing parameters, configuration information, and physical attributes. User-specific information can be written into the remaining 128 bytes of storage. READ/WRITE operations between the master (system logic) and the slave EEPROM device occur via a standard I2C bus using the DIMM’s SCL (clock) and SDA (data) signals, together with SA[2:0], which provide eight unique DIMM/EEPROM addresses. Write Protect (WP) is connected to Vss internal to the temperature sensor/EEPROM, permanently disabling hardware write protection.



## Electrical Specifications

Stresses greater than those listed in Table 6 may cause permanent damage to the module. This is a stress rating only, and functional operation of the module at these or any other conditions outside those indicated in each device's data sheet is not implied. Exposure to absolute maximum rating conditions for extended periods may adversely affect reliability.

**Table 6: Absolute Maximum Ratings**

| Symbol                             | Parameter  | Min  | Max    | Units |
|------------------------------------|--|------|--------|-------|
| V <sub>DD</sub>                    | V <sub>DD</sub> supply voltage relative to V <sub>SS</sub> | -0.4 | +1.975 | V     |
| V <sub>IN</sub> , V <sub>OUT</sub> | Voltage on any pin relative to V <sub>SS</sub>             | -0.4 | +1.975 | V     |

**Table 7: Operating Conditions**

| Symbol            | Parameter  | Min                           | Nom                   | Max                           | Units | Notes |         |
|-------------------|--|-------------------------------|-----------------------|-------------------------------|-------|-------|---------|
| V <sub>DD</sub>   | V <sub>DD</sub> supply voltage   | 1.425                         | 1.5                   | 1.575                         | V     |       |         |
| I <sub>VTT</sub>  | Termination reference current from V <sub>TT</sub>   | -600                          | -                     | +600                          | mA    |       |         |
| V <sub>TT</sub>   | Termination reference voltage (DC) – command/address bus   | 0.49 × V <sub>DD</sub> - 20mV | 0.5 × V <sub>DD</sub> | 0.51 × V <sub>DD</sub> + 20mV | V     | 1     |         |
| I <sub>I</sub>    | Input leakage current; Any input 0V ≤ V <sub>IN</sub> ≤ V <sub>DD</sub> ; V <sub>REF</sub> input 0V ≤ V <sub>IN</sub> ≤ 0.95V (All other pins not under test = 0V) | TBD                           | TBD                   | TBD                           | μA    |       |         |
|                   | Address inputs, RAS#, CAS#, WE#, S#, CKE, ODT, BA, CK, CK#   |                               |                       |                               |       |       |         |
|                   | DM   | -8                            | 0                     | +8                            |       |       |         |
| I <sub>OZ</sub>   | Output leakage current; 0V ≤ V <sub>OUT</sub> ≤ V <sub>DD</sub> ; DQ and ODT are disabled; ODT is HIGH   | -20                           | 0                     | +20                           | μA    |       |         |
|                   | DQ, DQS, DQS#  |                               |                       |                               |       |       |         |
| I <sub>VREF</sub> | V <sub>REF</sub> supply leakage current; V <sub>REFDQ</sub> = V <sub>DD</sub> /2 or V <sub>REFCA</sub> = V <sub>DD</sub> /2 (All other pins not under test = 0V)   | -36                           | 0                     | +36                           | μA    |       |         |
| T <sub>A</sub>    | Module ambient operating temperature   | Commercial                    | 0                     | -                             | +70   | °C    | 2, 3    |
|                   |  | Industrial                    | -40                   | -                             | +85   | °C    |         |
| T <sub>C</sub>    | DDR3 SDRAM component case operating temperature  | Commercial                    | 0                     | -                             | +95   | °C    | 2, 3, 4 |
|                   |  | Industrial                    | -40                   | -                             | +95   | °C    |         |

- Notes:
1. V<sub>TT</sub> termination voltage in excess of stated limit will adversely affect the command and address signals' voltage margin and will reduce timing margins.
  2. T<sub>A</sub> and T<sub>C</sub> are simultaneous requirements.
  3. For further information, refer to technical note TN-00-08: "Thermal Applications," available on Micron's Web site.
  4. Refresh rate is required to double when 85°C < T<sub>C</sub> ≤ 95°C.

## DRAM Operating Conditions

Recommended AC operating conditions are given in the DDR3 component data sheets. Component specifications are available on Micron's Web site. Module speed grades correlate with component speed grades, as shown in Table 8.

**Table 8: Module and Component Speed Grades**  
DDR3 components may exceed the listed module speed grades

| Module Speed Grade | Component Speed Grade |
|--------------------|-----------------------|
| -1G4               | -15E                  |
| -1G3               | -15                   |
| -1G1               | -187E                 |
| -1G0               | -187                  |
| -80C               | -25E                  |
| -80B               | -25                   |

## Design Considerations

### Simulations

Micron memory modules are designed to optimize signal integrity through carefully designed terminations, controlled board impedances, routing topologies, trace length matching, and decoupling. However, good signal integrity starts at the system level. Micron encourages designers to simulate the signal characteristics of the system's memory bus to ensure adequate signal integrity of the entire memory system.

### Power

Operating voltages are specified at the DRAM, not at the edge connector of the module. Designers must account for any system voltage drops at anticipated power levels to ensure the required supply voltage is maintained.

## IDD Specifications

**Table 9: DDR3 IDD Specifications and Conditions – 4GB**

Values are for the MT41J128M8 DDR3 SDRAM only and are computed from values specified in the 2Gb TwinDie (256 Meg x 8) component data sheet

| Parameter   | Symbol | 1333  | 1066  | 800   | Units |
|---|--------|-------|-------|-------|-------|
| Operating current 0: One bank ACTIVATE-to-PRECHARGE                       | IDD0   | 1,710 | 1,575 | 1,440 | mA    |
| Operating current 1: One bank ACTIVATE-to-READ-to-PRECHARGE               | IDD1   | 1,890 | 1,755 | 1,620 | mA    |
| Precharge power-down current: Slow exit                                   | IDD2P  | 360   | 360   | 360   | mA    |
| Precharge power-down current: Fast exit                                   | IDD2P  | 495   | 495   | 495   | mA    |
| Precharge quiet standby current   | IDD2Q  | 1,080 | 990   | 900   | mA    |
| Precharge standby current   | IDD2N  | 1,215 | 1,125 | 1,035 | mA    |
| Active power-down current   | IDD3P  | 585   | 540   | 495   | mA    |
| Active standby current  | IDD3N  | 1,260 | 1,170 | 1,080 | mA    |
| Burst read operating current  | IDD4R  | 2,520 | 2,115 | 1,800 | mA    |
| Burst write operating current   | IDD4W  | 2,430 | 2,115 | 1,800 | mA    |
| Refresh current   | IDD5B  | 2,880 | 2,655 | 2,430 | mA    |
| Self refresh temperature current: MAX T <sub>C</sub> = 85°C               | IDD6   | 216   | 216   | 216   | mA    |
| Self refresh temperature current (SRT-enabled): MAX T <sub>C</sub> = 95°C | IDD6ET | 324   | 324   | 324   | mA    |
| All banks interleaved read current  | IDD7   | 5,130 | 4,185 | 3,780 | mA    |

## Registering Clock Driver Specifications

**Table 10: Registering Clock Driver Electrical Characteristics**  
SSTE32882 devices or equivalent

| Symbol                 | Parameter                                   | Pins                              | Min                      | Nom              | Max                      | Units |
|------------------------|---|-----------------------------------|--------------------------|------------------|--------------------------|-------|
| VDD                    | DC supply voltage                           | -                                 | 1.425                    | 1.5              | 1.575                    | V     |
| VREF                   | DC reference voltage                        | -                                 | $0.49 \times VDD$        | $0.5 \times VDD$ | $0.051 \times VDD$       | V     |
| VTT                    | DC termination voltage                      | -                                 | $VREF - 40mV$            | VREF             | $VREF + 40mV$            | V     |
| V <sub>IH</sub> (AC)   | AC high-level input voltage                 | Control, command, address         | $VREF + 175mV$           | -                | $VDD + 400mV$            | V     |
| V <sub>IL</sub> (AC)   | AC low-level input voltage                  | Control, command, address         | -0.4                     | -                | $VREF - 175mV$           | V     |
| V <sub>IH</sub> (DC)   | DC high-level input voltage                 | Control, command, address         | $VREF + 100mV$           | -                | $VDD + 0.4$              | V     |
| V <sub>IL</sub> (DC)   | DC low-level input voltage                  | Control, command, address         | -0.4                     | -                | $VREF - 100mV$           | V     |
| V <sub>IH</sub> (CMOS) | High-level input voltage                    | RESET#, MIRROR                    | $0.65 \times VDD$        | -                | VDD                      | V     |
| V <sub>IL</sub> (CMOS) | Low-level input voltage                     | RESET#, MIRROR                    | 0                        | -                | $0.35 \times VDD$        | V     |
| V <sub>IX</sub> (AC)   | Differential input crosspoint voltage range | CK, CK#, FBIN, FBIN#              | $0.5 \times VDD - 175mV$ | $0.5 \times VDD$ | $0.5 \times VDD + 175mV$ | V     |
| V <sub>ID</sub> (AC)   | Differential input voltage                  | CK, CK#                           | 350                      | -                | $VDD + TBD$              | mV    |
| I <sub>OH</sub>        | High-level output current                   | All outputs except ERR_OUT#       | -                        | -                | TBD                      | mA    |
| I <sub>OL</sub>        | Low-level output current                    | All outputs except ERR_OUT#       | -                        | -                | TBD                      | mA    |
| I <sub>OL</sub>        | Low-level output current (ERR_OUT#)         | ERR_OUT#                          | TBD                      | -                | TBD                      | mA    |
| V <sub>OD</sub>        | Differential redriven clock swing           | Y <sub>n</sub> , Y <sub>n</sub> # | 500                      | -                | VDD                      | mV    |
| V <sub>OX</sub>        | Differential output crosspoint voltage      | Y <sub>n</sub> , Y <sub>n</sub> # | $0.5 \times VDD - 100mV$ | -                | $0.5 \times VDD + 100mV$ | V     |

Note: Timing and switching specifications for the register listed are critical for proper operation of the DDR3 SDRAM RDIMMs. These are meant to be a subset of the parameters for the specific device used on the module.

## Temperature Sensor with Serial Presence-Detect EEPROM

The temperature sensor continuously monitors the module's temperature and can be read back at any time over the I<sup>2</sup>C bus shared with the SPD EEPROM.

**Table 11: Temperature Sensor with Serial Presence-Detect EEPROM Operating Conditions**

| Parameter/Condition                   | Symbol | Min   | Max        | Units |
|---------------------------------------|--------|-------|------------|-------|
| Supply voltage                        | VDDSPD | +3.0  | +3.6       | V     |
| Supply current: VDD = 3.3V            | IDD    | –     | +2.0       | mA    |
| Input high voltage: Logic 1; SCL, SDA | VIH    | +1.45 | VDDSPD + 1 | V     |
| Input low voltage: Logic 0; SCL, SDA  | VIL    | –     | +0.55      | V     |
| Output low voltage: IOUT = 2.1mA      | VOL    | –     | +0.4       | V     |
| Input current                         | IIN    | –5.0  | +5.0       | μA    |
| Temperature sensing range             | –      | –40   | +125       | °C    |
| Temperature sensor accuracy (class B) | –      | –1.0  | +1.0       | °C    |

**Table 12: Sensor and EEPROM Serial Interface Timing**

| Parameter/Condition                                     | Symbol              | Min   | Max | Units |
|---|---------------------|-------|-----|-------|
| Time bus must be free before a new transition can start | <sup>t</sup> BUF    | 1.3   | –   | μs    |
| SDA fall time   | <sup>t</sup> F      | 20    | 300 | ns    |
| SDA rise time   | <sup>t</sup> R      | –     | 300 | ns    |
| Data-out hold time                                      | <sup>t</sup> HD:DAT | 200   | 900 | ns    |
| Clock pulse width HIGH time                             | <sup>t</sup> HIGH   | 600   | –   | ns    |
| Clock pulse width LOW time                              | <sup>t</sup> LOW    | 1,300 | –   | ns    |
| SCL clock frequency                                     | <sup>f</sup> SCL    | 10    | 400 | kHz   |
| Data setup time   | <sup>t</sup> SU:DAT | 100   | –   | ns    |
| Start condition setup time                              | <sup>t</sup> SU:STA | 600   | –   | ns    |
| Stop condition setup time                               | <sup>t</sup> SU:STO | 600   | –   | ns    |

### EVENT# Pin

The temperature sensor also adds the EVENT# pin (open drain). Not used by the SPD EEPROM, the EVENT# is a temperature sensor output used to flag critical events that can be set up in the sensor's configuration register.

EVENT# has three defined modes of operation: interrupt mode, compare mode, and critical temperature mode. The open-drain output of EVENT# under the three separate operating modes is illustrated in Figure 3 on page 14. Event thresholds are programmed in the 0x01 register using a hysteresis. The alarm window provides a comparison window, with upper and lower limits set in the alarm upper boundary register and the alarm lower boundary register, respectively. When the alarm window is enabled, EVENT# will trigger whenever the temperature is outside the MIN or MAX values set by the user.

The interrupt mode enables software to reset EVENT# after a critical temperature threshold has been detected. Threshold points are set in the configuration register by the user. This mode triggers the critical temperature limit and both the MIN and MAX of the temperature window.

The compare mode is similar to the interrupt mode, except EVENT# cannot be reset by the user and only returns to the logic HIGH state when the temperature falls below the programmed thresholds.

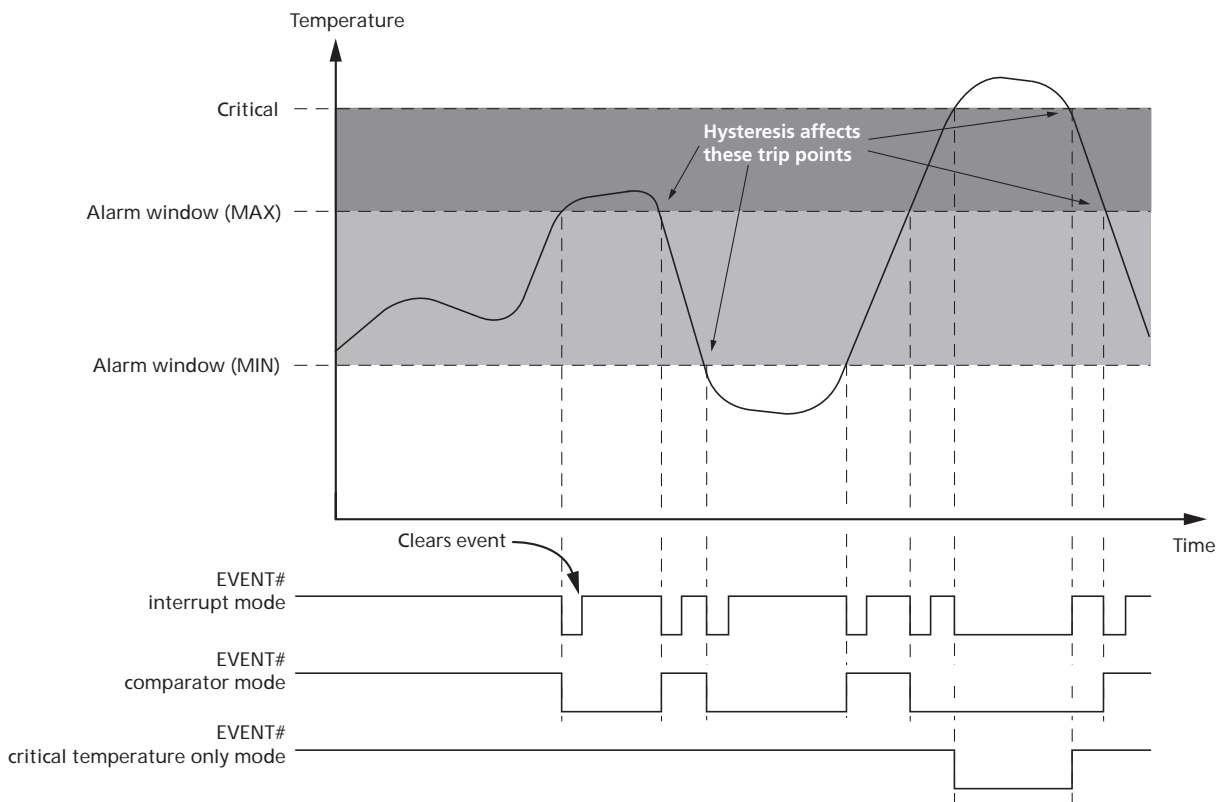
Critical temperature mode triggers EVENT# only when the temperature has exceeded the programmed critical trip point. When the critical trip point has been reached, the temperature sensor goes into comparator mode, and the critical EVENT# cannot be cleared through software.

### SM Bus Slave Subaddress Decoding

The temperature sensor's physical address differs from the SPD EEPROM's physical address: 0011 for A0, A1, A2, and RW# in binary where A2, A1, and A0 are the three slave subaddress pins and the RW# bit is the READ/WRITE flag.

If the slave base address is fixed for the temperature sensor/SPD EEPROM, then the pins set the subaddress bits of the slave address, enabling the devices to be located anywhere within the eight slave address locations. For example, they could be set from 30h to 3Eh.

Figure 3: EVENT# Pin Functionality



**Table 13: Temperature Sensor Registers**

| Name                                      | Address        | Power-On Default |
|---|----------------|------------------|
| Pointer register                          | Not applicable | Undefined        |
| Capability register                       | 0x00           | 0x0001           |
| Configuration register                    | 0x01           | 0x0000           |
| Alarm temperature upper boundary register | 0x02           | 0x0000           |
| Alarm temperature lower boundary register | 0x03           | 0x0000           |
| Critical temperature register             | 0x04           | 0x0000           |
| Temperature register                      | 0x05           | Undefined        |

## Pointer Register

The pointer register selects which of the 16-bit registers is being accessed in subsequent READ and WRITE operations. This register is a write-only register.

**Table 14: Pointer Register Bits 0-7**

| Bit |   |   |   |                 |                 |                 |                 |
|-----|---|---|---|-----------------|-----------------|-----------------|-----------------|
| 7   | 6 | 5 | 4 | 3               | 2               | 1               | 0               |
| 0   | 0 | 0 | 0 | Register select | Register select | Register select | Register select |

**Table 15: Pointer Register Bits 0-2 Descriptions**

| Bit |   |   | Register                                  |
|-----|---|---|---|
| 2   | 1 | 0 |   |
| 0   | 0 | 0 | Capability register                       |
| 0   | 0 | 1 | Configuration register                    |
| 0   | 1 | 0 | Alarm temperature upper boundary register |
| 0   | 1 | 1 | Alarm temperature lower boundary register |
| 1   | 0 | 0 | Critical temperature register             |
| 1   | 0 | 1 | Temperature register                      |

## Capability Register

The capability register indicates the features and functionality supported by the temperature sensor. This register is a read-only register.

**Table 16: Capability Register (Address: 0x00)**

| Bit |     |     |                        |     |             |           |                                    |
|-----|-----|-----|------------------------|-----|-------------|-----------|------------------------------------|
| 15  | 14  | 13  | 12                     | 11  | 10          | 9         | 8                                  |
| RFU | RFU | RFU | RFU                    | RFU | RFU         | RFU       | RFU                                |
| Bit |     |     |                        |     |             |           |                                    |
| 7   | 6   | 5   | 4                      | 3   | 2           | 1         | 0                                  |
| RFU | RFU | RFU | Temperature resolution |     | Wider range | Precision | Has alarm and critical temperature |

**Table 17: Capability Register Bit Descriptions**

| Bit  | Description  |
|------|--|
| 0    | Basic capability<br>1: Has alarm and critical trip point capabilities  |
| 1    | Accuracy<br>0: $\pm 2^{\circ}\text{C}$ over the active range and $\pm 3^{\circ}\text{C}$ over the monitor range<br>1: $\pm 1^{\circ}\text{C}$ over the active range and $\pm 2^{\circ}\text{C}$ over the monitor range |
| 2    | Wider range<br>0: Temperatures lower than $0^{\circ}\text{C}$ are clamped to a binary value of 0<br>1: Temperatures below $0^{\circ}\text{C}$ can be read  |
| 4:3  | Temperature resolution<br>00: $0.5^{\circ}\text{C}$ LSB<br>01: $0.25^{\circ}\text{C}$ LSB<br>10: $0.125^{\circ}\text{C}$ LSB<br>11: $0.0625^{\circ}\text{C}$ LSB   |
| 15:5 | 0: Must be set to zero   |

## Configuration Register

**Table 18: Configuration Register (Address: 0x01)**

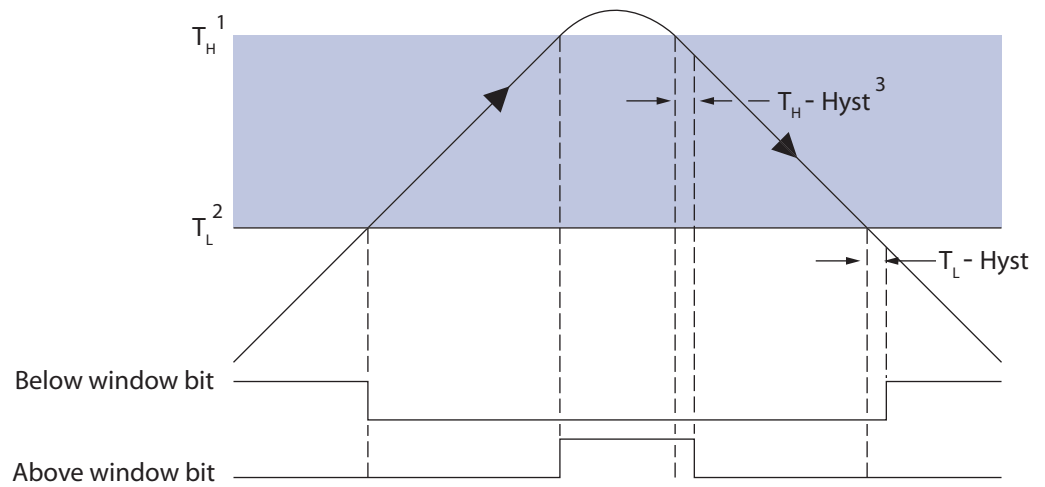
| Bit               |                |             |                     |                      |                     |                |               |
|-------------------|----------------|-------------|---------------------|----------------------|---------------------|----------------|---------------|
| 15                | 14             | 13          | 12                  | 11                   | 10                  | 9              | 8             |
| RFU               | RFU            | RFU         | RFU                 | RFU                  | Hysteresis          |                | Shutdown mode |
| Bit               |                |             |                     |                      |                     |                |               |
| 7                 | 6              | 5           | 4                   | 3                    | 2                   | 1              | 0             |
| Critical lock bit | Alarm lock bit | Clear event | Event output status | Event output control | Critical event only | Event polarity | Event mode    |



**Table 19: Configuration Register Bit Descriptions**

| Bit  | Description  | Notes   |
|------|--|---|
| 0    | Event mode<br>0: Comparator mode<br>1: Interrupt mode  | Event mode cannot be changed if either of the lock bits is set.   |
| 1    | EVENT# polarity<br>0: Active LOW<br>1: Active HIGH   | EVENT# polarity cannot be changed if either of the lock bits is set.  |
| 2    | Critical event only<br>0: EVENT# trips on alarm or critical temperature event<br>1: EVENT# trips only if critical temperature is reached               |   |
| 3    | Event output control<br>0: Event output disabled<br>1: Event output enabled  |   |
| 4    | Event status<br>0: EVENT# has not been asserted by this device<br>1: EVENT# is being asserted due to an alarm window or critical temperature condition | This is a read-only field in the register. The event causing the event can be determined from the read temperature register.  |
| 5    | Clear event<br>0: No effect<br>1: Clears the event when the temperature sensor is in the interrupt mode  |   |
| 6    | Alarm window lock bit<br>0: Alarm trips are not locked and can be changed<br>1: Alarm trips are locked and cannot be changed                           |   |
| 7    | Critical trip lock bit<br>0: Critical trip is not locked and can be changed<br>1: Critical trip is locked and cannot be changed                        |   |
| 8    | Shutdown mode<br>0: Enabled<br>1: Shutdown   | The shutdown mode is a power-saving mode that disables the temperature sensor.  |
| 10:9 | Hysteresis enable<br>00: Disable<br>01: Enable at 1.5°C<br>10: Enable at 3°C<br>11: Enable at 6°C  | When enabled, a hysteresis is applied to temperature movement around the trip points. As an example, if the hysteresis register is enabled to a delta of 6°C, the preset trip points will toggle when the temperature reaches the programmed value. These values will reset when the temperature drops below the trip points minus the set hysteresis level. In this case, this would be critical temperature minus 6°C.<br><br>The hysteresis is applied both to the above alarm window and the below alarm window bits found in the read-only temperature register. EVENT# is also affected by this register. |

Figure 4: Hysteresis



- Notes:
1.  $T_H$  is the value set in the alarm temperature upper boundary trip register.
  2.  $T_L$  is the value set in the alarm temperature lower boundary trip register.
  3. Hyst is the value set in the hysteresis bits of the configuration register.

Table 20: Hysteresis

| Condition | Below Alarm Window Bit |                      | Above Alarm Window Bit |                      |
|-----------|------------------------|----------------------|------------------------|----------------------|
|           | Temperature Gradient   | Critical Temperature | Temperature Gradient   | Critical Temperature |
| Sets      | Falling                | $T_L - \text{Hyst}$  | Rising                 | $T_H$                |
| Clears    | Rising                 | $T_L$                | Falling                | $T_H - \text{Hyst}$  |

## Temperature Format

The temperature trip point registers and temperature readout register use a “2’s complement” format to enable negative numbers. The least significant bit (LSB) is equal to 0.0625°C or 0.25°C depending on which register is referenced. As an example, assuming an LSB of 0.0625°C:

- A value of 0x018C would equal 24.75°C
- A value of 0x06C0 would equal 108°C
- A value of 0x1E74 would equal -24.75°C

## Temperature Trip Point Registers

The upper and lower temperature boundary registers are used to set the maximum and minimum values of the alarm window. The LSB for these registers is 0.25°C. All RFU bits in the register will always report zero.

**Table 21: Alarm Temperature Upper Boundary Register (Address: 0x02)**

| Bit                                     |    |    |     |    |    |   |   |   |   |   |   |   |     |     |     |
|---|----|----|-----|----|----|---|---|---|---|---|---|---|-----|-----|-----|
| 15                                      | 14 | 13 | 12  | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2   | 1   | 0   |
| 0                                       | 0  | 0  | MSB |    |    |   |   |   |   |   |   |   | LSB | RFU | RFU |
| Alarm window upper boundary temperature |    |    |     |    |    |   |   |   |   |   |   |   |     |     |     |

**Table 22: Alarm Temperature Lower Boundary Register (Address: 0x03)**

| Bit                                     |    |    |     |    |    |   |   |   |   |   |   |   |     |     |     |
|---|----|----|-----|----|----|---|---|---|---|---|---|---|-----|-----|-----|
| 15                                      | 14 | 13 | 12  | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2   | 1   | 0   |
| 0                                       | 0  | 0  | MSB |    |    |   |   |   |   |   |   |   | LSB | RFU | RFU |
| Alarm window lower boundary temperature |    |    |     |    |    |   |   |   |   |   |   |   |     |     |     |

## Critical Temperature Register

The critical temperature register is used to set the maximum temperature above the alarm window. The LSB for this register is 0.25°C. All RFU bits in the register will always report zero.

**Table 23: Critical Temperature Register (Address: 0x04)**

| Bit                             |    |    |     |    |    |   |   |   |   |   |   |   |     |     |     |
|---------------------------------|----|----|-----|----|----|---|---|---|---|---|---|---|-----|-----|-----|
| 15                              | 14 | 13 | 12  | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2   | 1   | 0   |
| 0                               | 0  | 0  | MSB |    |    |   |   |   |   |   |   |   | LSB | RFU | RFU |
| Critical temperature trip point |    |    |     |    |    |   |   |   |   |   |   |   |     |     |     |

## Temperature Register

The temperature register is a read-only register that provides the current temperature detected by the temperature sensor. The LSB for this register is 0.0625°C with a resolution of 0.0625°C. The most significant bit (MSB) is 128°C in the readout section of this register.

The upper three bits of the register are used to monitor the trip points that are set in the previous three registers.

**Table 24: Temperature Register (Address: 0x05)**

| Bit                 |                    |                    |     |             |    |   |   |   |   |   |   |   |   |   |     |
|---------------------|--------------------|--------------------|-----|-------------|----|---|---|---|---|---|---|---|---|---|-----|
| 15                  | 14                 | 13                 | 12  | 11          | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0   |
| Above critical trip | Above alarm window | Below alarm window | MSB | Temperature |    |   |   |   |   |   |   |   |   |   | LSB |

**Table 25: Temperature Register Bit Descriptions**

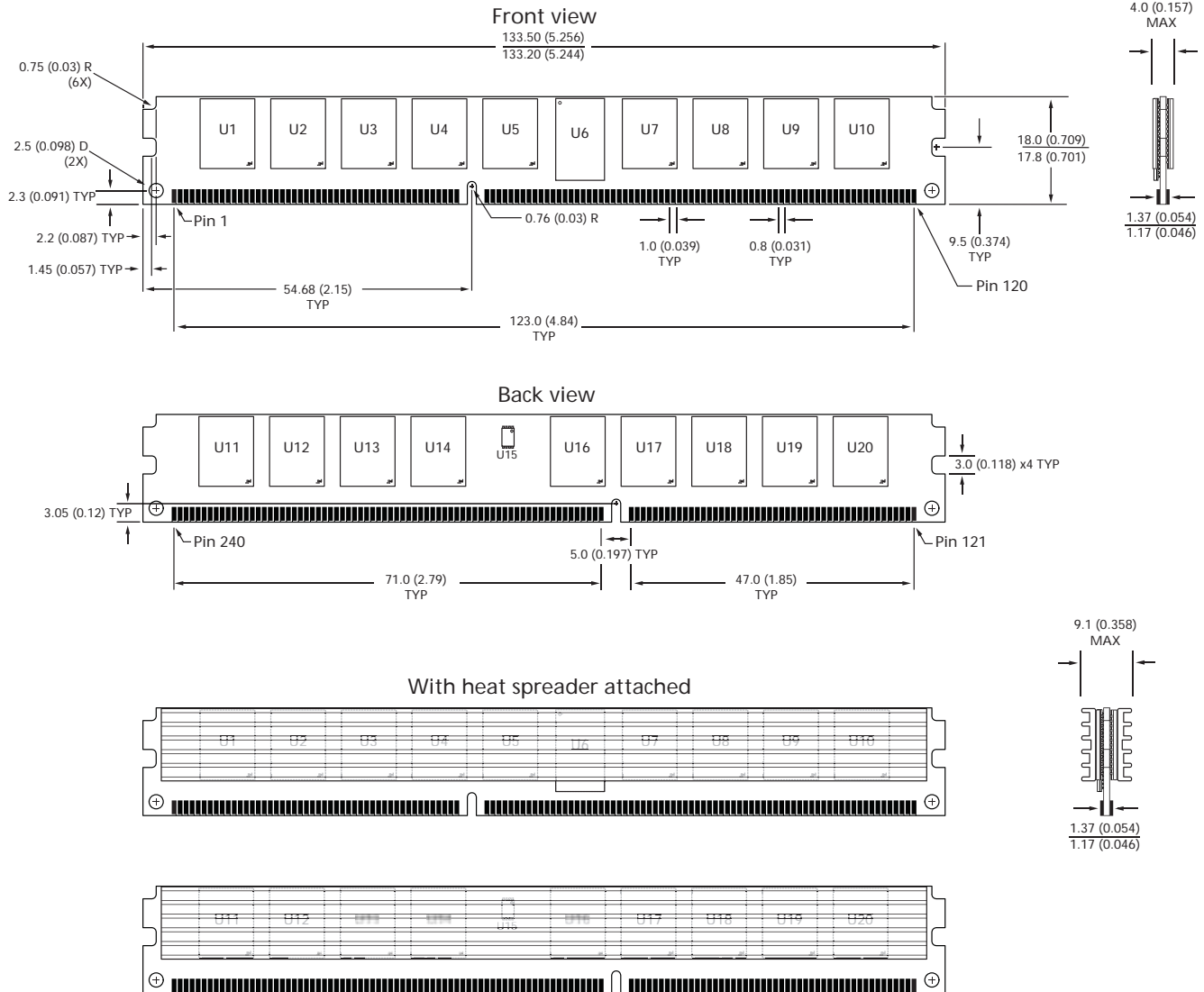
| Bit | Description   |
|-----|---|
| 13  | Below alarm window<br>0: Temperature is equal to or above the lower boundary<br>1: Temperature is below alarm window    |
| 14  | Above alarm window<br>0: Temperature is equal to or below the upper boundary<br>1: Temperature is above alarm window    |
| 15  | Above critical trip point<br>0: Temperature is below critical trip point<br>1: Temperature is above critical trip point |

## Serial Presence-Detect

For the latest serial presence-detect data, refer to Micron's SPD page:  
[www.micron.com/SPD](http://www.micron.com/SPD).

## Module Dimensions

Figure 5: 240-Pin DDR3 RDIMM



- Notes: 1. All dimensions are in millimeters (inches); MAX/MIN or typical (TYP) where noted.  
 2. The dimensional diagram is for reference only.



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This data sheet contains minimum and maximum limits specified over the power supply and temperature range set forth herein. Although considered final, these specifications are subject to change, as further product development and data characterization sometimes occur.



## Revision History

|              |   |               |
|--------------|---|---------------|
| Rev. A ..... |   | <b>.07/08</b> |
|              | <ul style="list-style-type: none"><li>• Initial release</li></ul> |               |
|              | PCB 0735 referenced.  |               |